

SN54ALS569A, SN74ALS568A, SN74ALS569A SYNCHRONOUS 4-BIT UP/DOWN DECADE AND BINARY COUNTERS WITH 3-STATE OUTPUTS

SDAS229A – APRIL 1982 – REVISED JANUARY 1995

- 3-State Q Outputs Drive Bus Lines Directly
- Counter Operation Independent of 3-State Output
- Fully Synchronous Clear, Count, and Load
- Asynchronous Clear Is Also Provided
- Fully Cascadable
- Package Options Include Plastic Small-Outline (DW) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

description

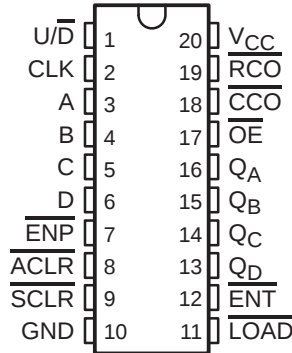
The SN74ALS568A decade counter and 'ALS569A binary counters are programmable, count up or down, and offer both synchronous and asynchronous clearing. All synchronous functions are executed on the positive-going edge of the clock (CLK) input.

The clear function is initiated by applying a low level to either asynchronous clear ($\overline{\text{ACLR}}$) or synchronous clear ($\overline{\text{SCLR}}$). Asynchronous (direct) clearing overrides all other functions of the device, while synchronous clearing overrides only the other synchronous functions. Data is loaded from the A, B, C, and D inputs by holding load ($\overline{\text{LOAD}}$) low during a positive-going clock transition. The counting function is enabled only when enable P ($\overline{\text{ENP}}$) and enable T ($\overline{\text{ENT}}$) are low and $\overline{\text{ACLR}}$, $\overline{\text{SCLR}}$, and $\overline{\text{LOAD}}$ are high. The up/down ($\text{U}/\overline{\text{D}}$) input controls the direction of the count. These counters count up when $\text{U}/\overline{\text{D}}$ is high and count down when $\text{U}/\overline{\text{D}}$ is low.

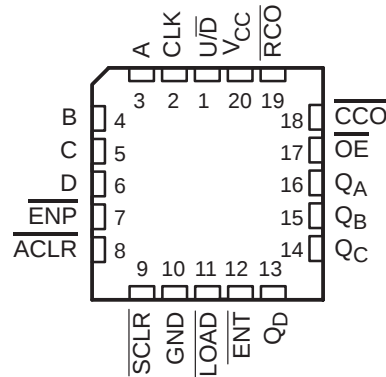
A high level at the output-enable ($\overline{\text{OE}}$) input forces the Q outputs into the high-impedance state, and a low level enables those outputs. Counting is independent of $\overline{\text{OE}}$. $\overline{\text{ENT}}$ is fed forward to enable the ripple-carry output ($\overline{\text{RCO}}$) to produce a low-level pulse while the count is zero (all Q outputs low) when counting down or maximum (9 or 15) when counting up. The clocked carry output ($\overline{\text{CCO}}$) produces a low-level pulse for a duration equal to that of the low level of the clock when $\overline{\text{RCO}}$ is low and the counter is enabled (both $\overline{\text{ENP}}$ and $\overline{\text{ENT}}$ are low); otherwise, $\overline{\text{CCO}}$ is high. $\overline{\text{CCO}}$ does not have the glitches commonly associated with a ripple-carry output. Cascading is normally accomplished by connecting $\overline{\text{RCO}}$ or $\overline{\text{CCO}}$ of the first counter to $\overline{\text{ENT}}$ of the next counter. However, for very high-speed counting, $\overline{\text{RCO}}$ should be used for cascading since $\overline{\text{CCO}}$ does not become active until the clock returns to the low level.

The SN54ALS569A is characterized for operation over the full military temperature range of -55°C to 125°C . The SN74ALS568A and SN74ALS569A are characterized for operation from 0°C to 70°C .

SN54ALS569A . . . J PACKAGE
SN74ALS568A, SN74ALS569A . . . DW OR N PACKAGE
(TOP VIEW)



SN54ALS569A . . . FK PACKAGE
(TOP VIEW)



SN54ALS569A, SN74ALS568A, SN74ALS569A

SYNCHRONOUS 4-BIT UP/DOWN DECADE AND BINARY COUNTERS

WITH 3-STATE OUTPUTS

SDAS229A – APRIL 1982 – REVISED JANUARY 1995

FUNCTION TABLE

INPUTS								OPERATION
$\overline{OE}$	$\overline{ACLR}$	$\overline{SCLR}$	$\overline{LOAD}$	$\overline{ENT}$	$\overline{ENP}$	$U/\overline{D}$	CLK	
H	X	X	X	X	X	X	X	Q outputs disabled
L	L	X	X	X	X	X	X	Asynchronous clear
L	H	L	X	X	X	X	↑	Synchronous clear
L	H	H	L	X	X	X	↑	Load
L	H	H	H	L	L	H	↑	Count up
L	H	H	H	L	L	L	↑	Count down
L	H	H	H	H	X	X	X	Inhibit count
L	H	H	H	X	H	X	X	Inhibit count

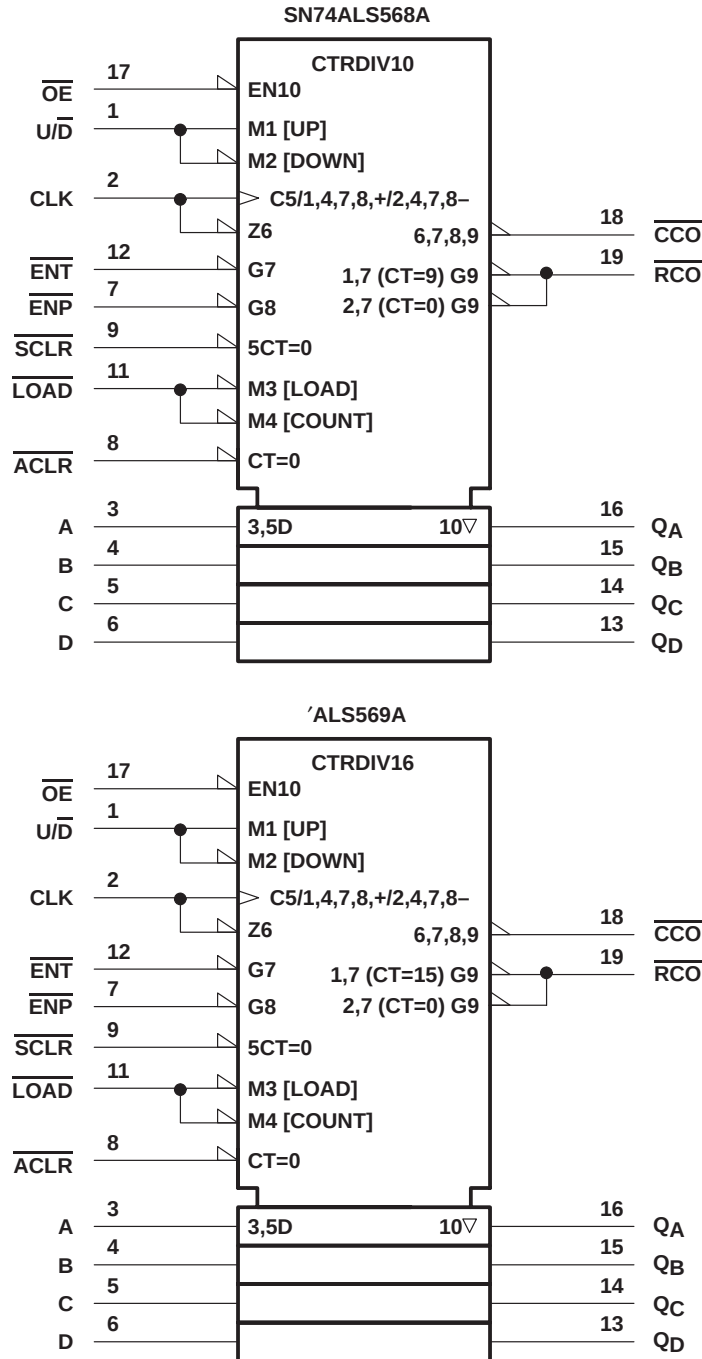


POST OFFICE BOX 655303 • DALLAS, TEXAS 75265

SN54ALS569A, SN74ALS568A, SN74ALS569A SYNCHRONOUS 4-BIT UP/DOWN DECADE AND BINARY COUNTERS WITH 3-STATE OUTPUTS

SDAS229A – APRIL 1982 – REVISED JANUARY 1995

logic symbols[†]



[†] These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

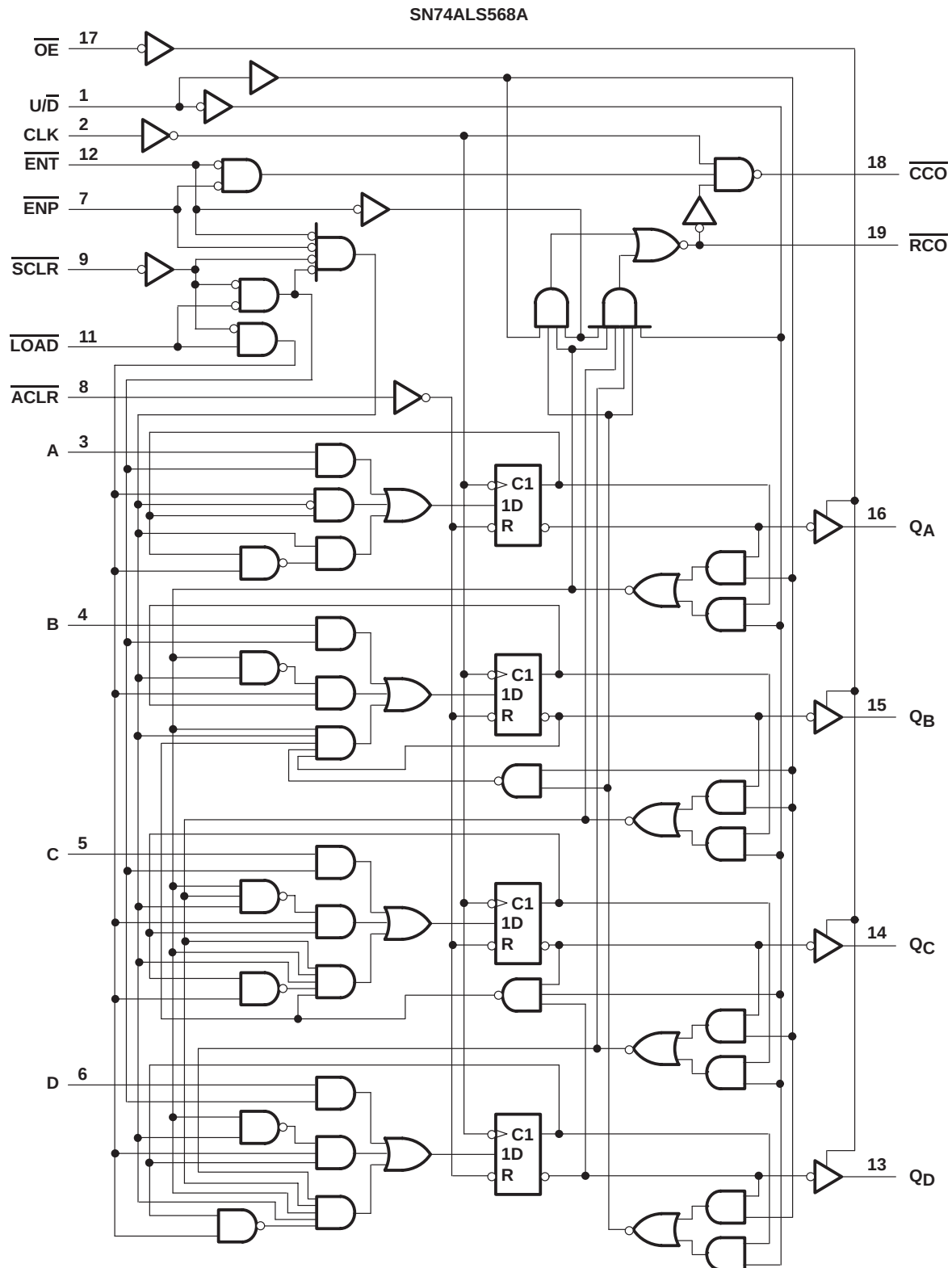
SN54ALS569A, SN74ALS568A, SN74ALS569A

SYNCHRONOUS 4-BIT UP/DOWN DECADE AND BINARY COUNTERS

WITH 3-STATE OUTPUTS

SDAS229A – APRIL 1982 – REVISED JANUARY 1995

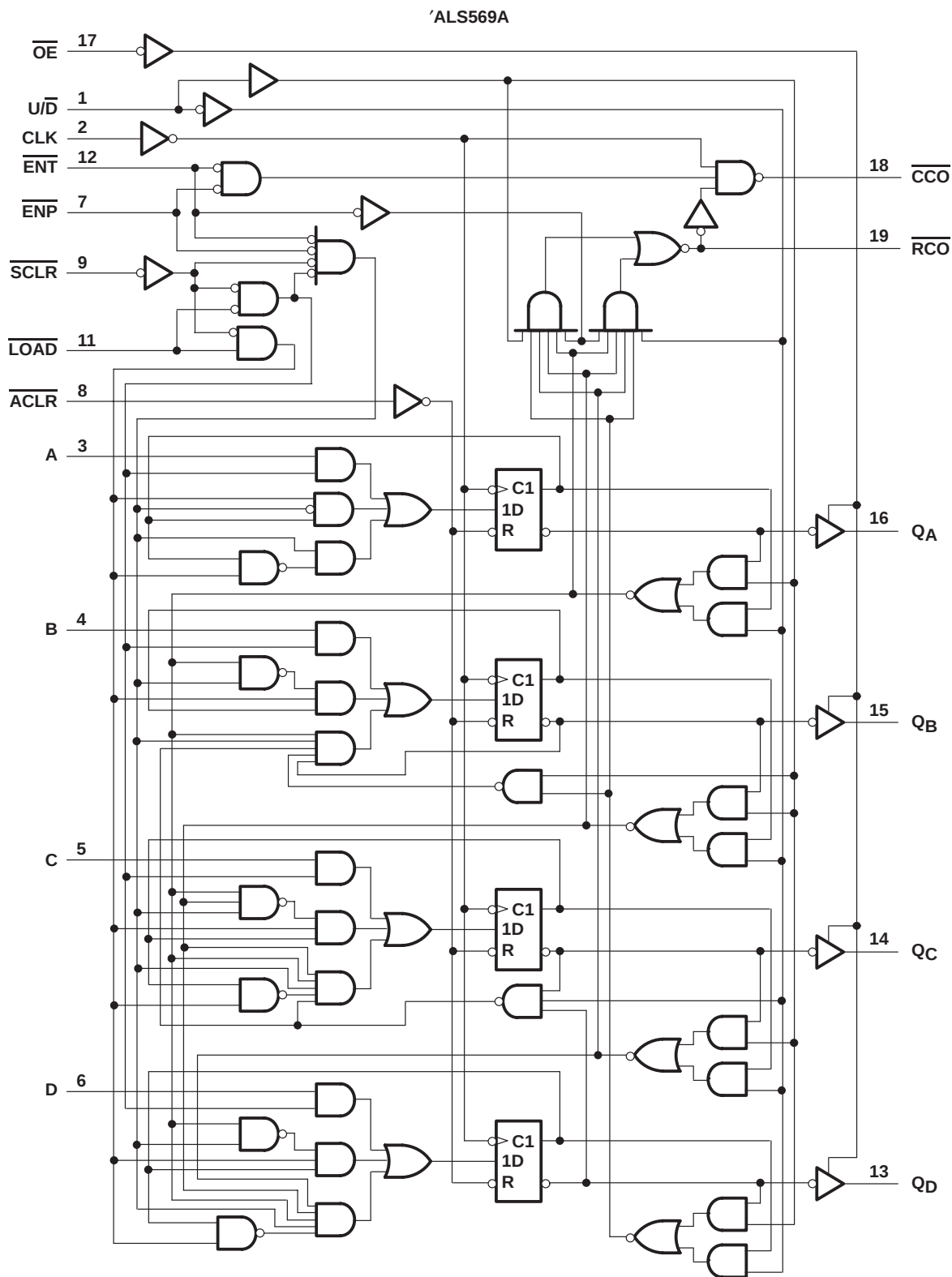
logic diagrams (positive logic)



SN54ALS569A, SN74ALS568A, SN74ALS569A
 SYNCHRONOUS 4-BIT UP/DOWN DECADE AND BINARY COUNTERS
 WITH 3-STATE OUTPUTS

SDAS229A – APRIL 1982 – REVISED JANUARY 1995

logic diagrams (positive logic) (continued)



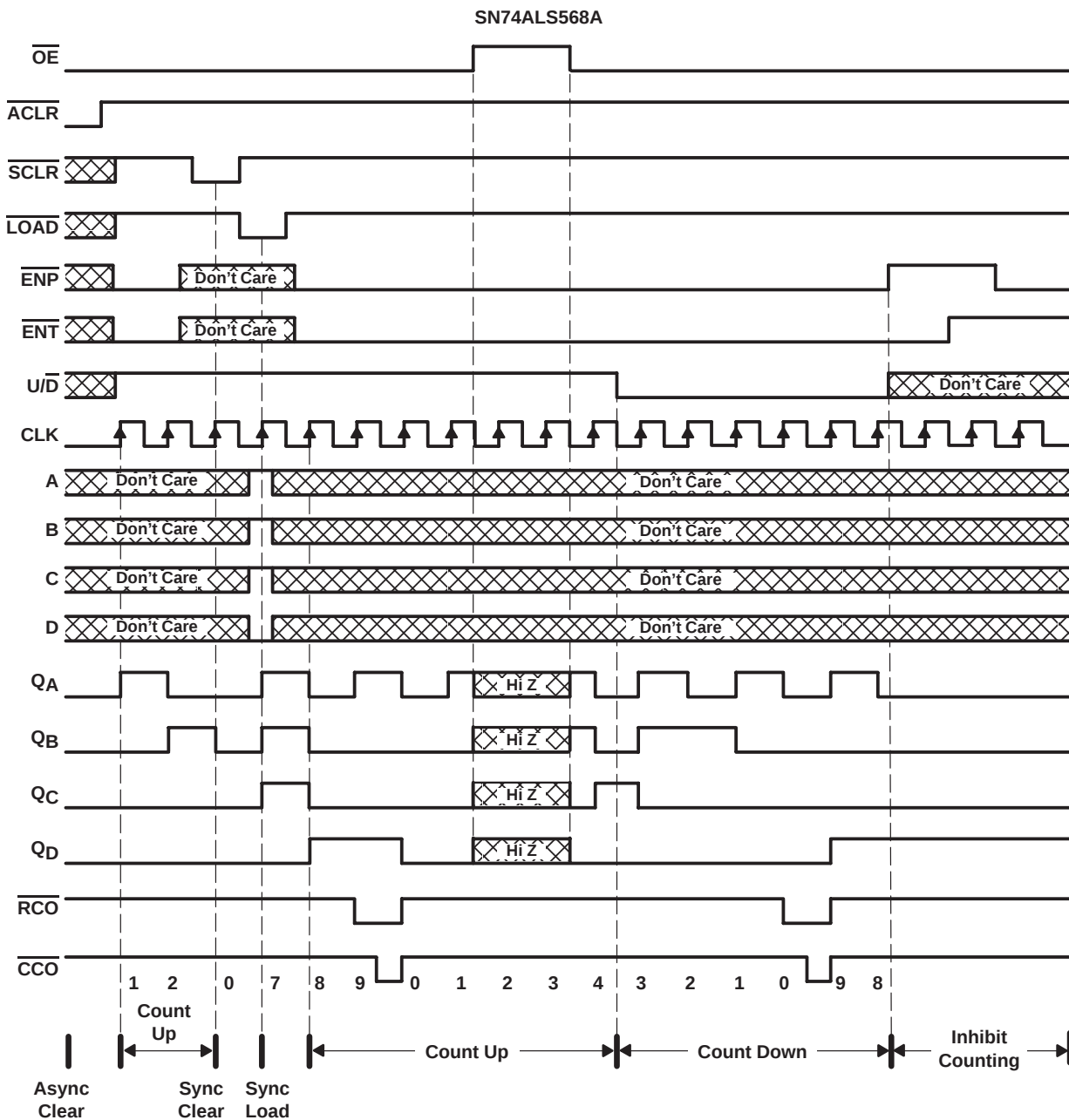
SN54ALS569A, SN74ALS568A, SN74ALS569A

SYNCHRONOUS 4-BIT UP/DOWN DECADE AND BINARY COUNTERS

WITH 3-STATE OUTPUTS

SDAS229A – APRIL 1982 – REVISED JANUARY 1995

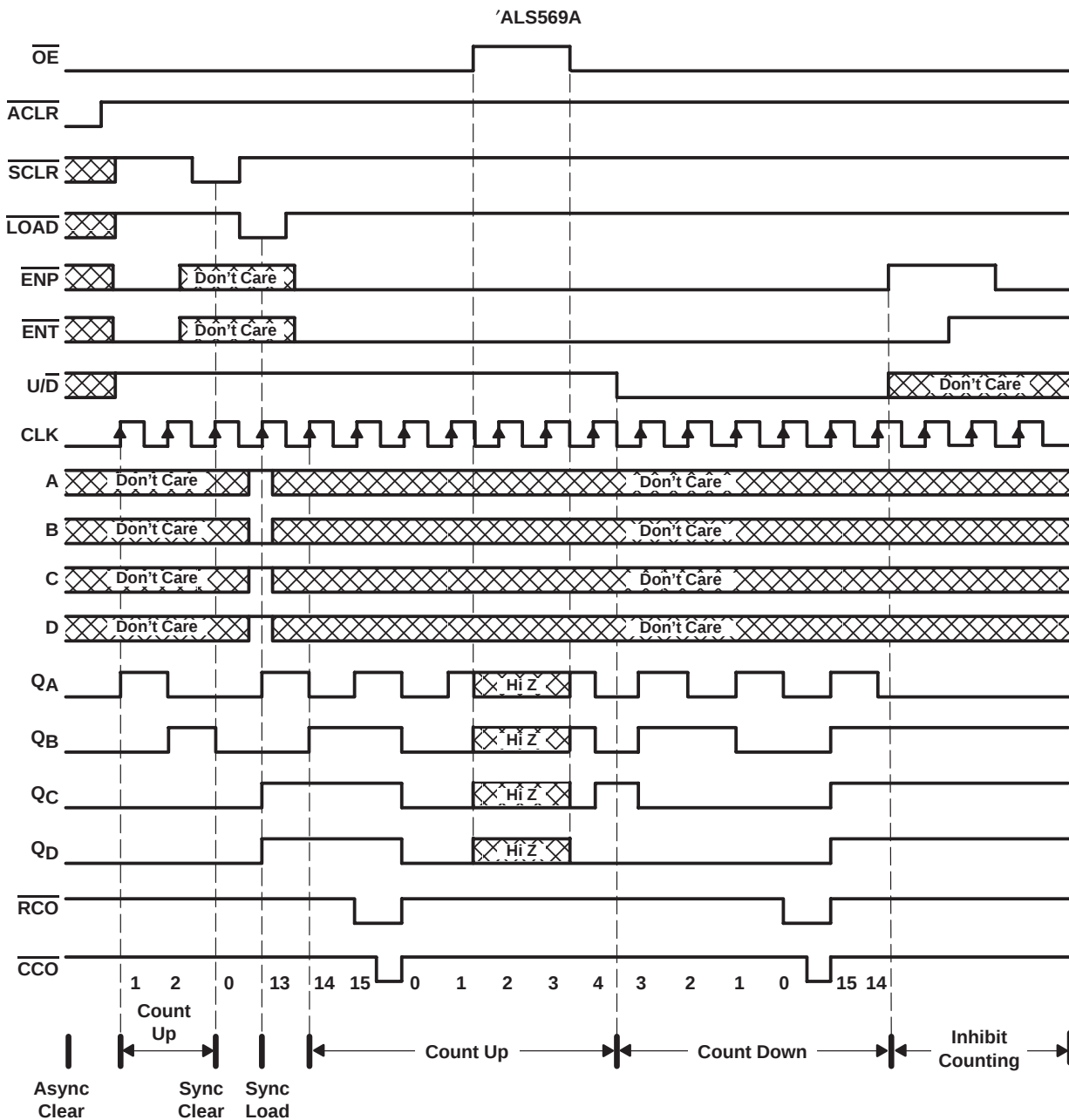
typical load, count, and inhibit sequences



SN54ALS569A, SN74ALS568A, SN74ALS569A SYNCHRONOUS 4-BIT UP/DOWN DECADE AND BINARY COUNTERS WITH 3-STATE OUTPUTS

SDAS229A – APRIL 1982 – REVISED JANUARY 1995

typical load, count, and inhibit sequences (continued)



SN54ALS569A, SN74ALS568A, SN74ALS569A

SYNCHRONOUS 4-BIT UP/DOWN DECADE AND BINARY COUNTERS

WITH 3-STATE OUTPUTS

SDAS229A – APRIL 1982 – REVISED JANUARY 1995

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage, V_{CC}	7 V
Input voltage, V_I	7 V
Voltage applied to a disabled 3-state output	5.5 V
Operating free-air temperature range, T_A : SN54ALS569A	–55°C to 125°C
SN74ALS568A, SN74ALS569A	0°C to 70°C
Storage temperature range	–65°C to 150°C

[†] Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

				SN54ALS569A			SN74ALS568A SN74ALS569A			UNIT		
				MIN	NOM	MAX	MIN	NOM	MAX			
V _{CC}	Supply voltage			4.5	5	5.5	4.5	5	5.5	V		
V _{IH}	High-level input voltage			2			2			V		
V _{IL}	Low-level input voltage			0.7			0.8			V		
I _{OH}	High-level output current	Q outputs		−1			−2.6			mA		
		$\overline{CCO}$ and $\overline{RCO}$		−0.4			−0.4					
I _{OL}	Low-level output current	Q outputs		12			24			mA		
		$\overline{CCO}$ and $\overline{RCO}$		4			8					
f _{clock}	Clock frequency	SN74ALS568A					0			20	MHz	
		'ALS569A		0			22			30		
t _w	Pulse duration	$\overline{ACLR}$ or $\overline{LOAD}$ low		20			15			ns		
		SN74ALS568A	CLK high					25				
			CLK low					25				
		'ALS569A	CLK high		20			16.5				
			CLK low		23			16.5				
t _{su}	Setup time before CLK↑	Data at A, B, C, D		25			20			ns		
		$\overline{ENP}$, $\overline{ENT}$	High		35			30				
			Low		25			20				
		$\overline{SCLR}$	Low		20			15				
			High (inactive)		35			30				
		$\overline{LOAD}$	Low		20			15				
			High (inactive)		35			30				
		U/ $\overline{D}$		35			30					
$\overline{ACLR}$ inactive		10			10							
t _h	Hold time after CLK↑ for any input			0			0			ns		
T _A	Operating free-air temperature			−55			125			0	70	°C



SN54ALS569A, SN74ALS568A, SN74ALS569A

SYNCHRONOUS 4-BIT UP/DOWN DECADE AND BINARY COUNTERS

WITH 3-STATE OUTPUTS

SDAS229A – APRIL 1982 – REVISED JANUARY 1995

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		SN54ALS569A			SN74ALS568A SN74ALS569A			UNIT
				MIN	TYP†	MAX	MIN	TYP†	MAX	
V _{IK}		V _{CC} = 4.5 V,	I _I = −18 mA	−1.5			−1.5			V
V _{OH}	All outputs	V _{CC} = 4.5 V to 5.5 V,	I _{OH} = −0.4 mA	V _{CC} − 2			V _{CC} − 2			V
	Q outputs	V _{CC} = 4.5 V	I _{OH} = −1 mA	2.4	3.3					
			I _{OH} = −2.6 mA				2.4	3.2		
V _{OL}	Q outputs	V _{CC} = 4.5 V	I _{OL} = 12 mA	0.25 0.4			0.25 0.4			V
			I _{OL} = 24 mA				0.35 0.5			
	$\overline{\text{CCO}}$ and $\overline{\text{RCO}}$	V _{CC} = 4.5 V	I _{OL} = 4 mA	0.25 0.4			0.25 0.4			
			I _{OL} = 8 mA				0.35 0.5			
I _{OZH}		V _{CC} = 5.5 V,	V _O = 2.7 V	20			20			μA
I _{OZL}		V _{CC} = 5.5 V,	V _O = 0.4 V	−20			−20			μA
I _I		V _{CC} = 5.5 V,	V _I = 7 V	0.1			0.1			mA
I _{IH}		V _{CC} = 5.5 V,	V _I = 2.7 V	20			20			μA
I _{IL}		V _{CC} = 5.5 V,	V _I = 0.4 V	−0.2			−0.2			mA
I _{O±}	$\overline{\text{CCO}}$ and $\overline{\text{RCO}}$	V _{CC} = 5.5 V,	V _O = 2.25 V	−15	−70	−15	−70	mA		
	Q outputs			−20	−112	−30	−112			
I _{CC}		V _{CC} = 5.5 V	Outputs high	16	26	16	26	mA		
			Outputs low	20	32	20	32			
			Outputs disabled	20	32	20	32			

[†] All typical values are at $V_{CC} = 5\text{ V}$, $T_A = 25^\circ\text{C}$.

[‡] The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, I_{OS} .

SN54ALS569A, SN74ALS568A, SN74ALS569A

SYNCHRONOUS 4-BIT UP/DOWN DECADE AND BINARY COUNTERS

WITH 3-STATE OUTPUTS

SDAS229A – APRIL 1982 – REVISED JANUARY 1995

switching characteristics (see Figure 1)

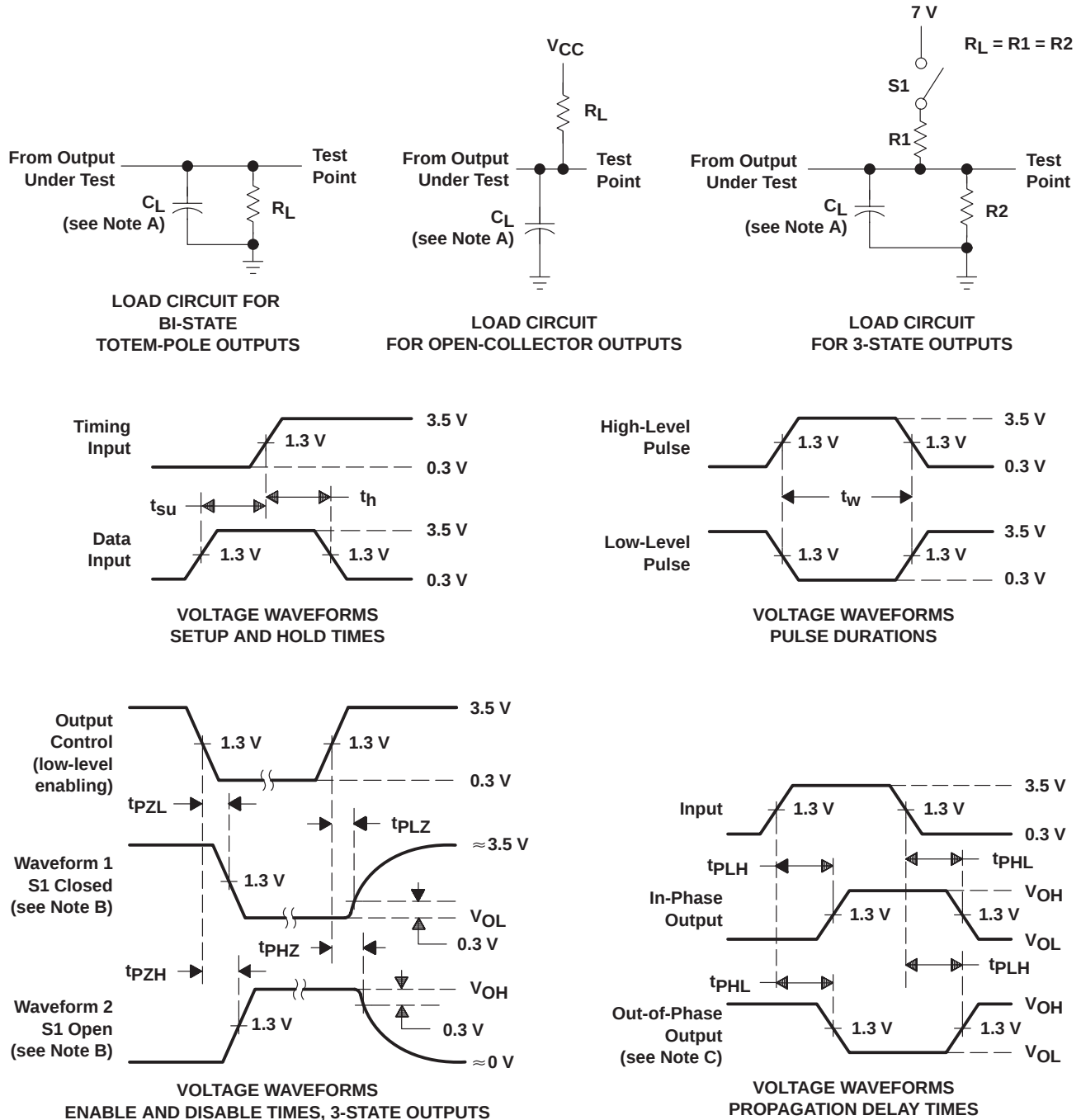
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC} = 4.5 V to 5.5 V, C _L = 50 pF, R ₁ = 500 Ω, R ₂ = 500 Ω, T _A = MIN to MAX [†]				UNIT
			SN54ALS569A		SN74ALS568A SN74ALS569A		
			MIN	MAX	MIN	MAX	
f _{max}	SN74ALS568A				20		MHz
	'ALS569A		22		30		
t _{PLH}	CLK	Any Q	4	21	4	13	ns
t _{PHL}			7	19	7	16	
t _{PLH}	CLK	$\overline{RCO}$	12	37	12	28	ns
t _{PHL}			10	28	10	19	
t _{PLH}	CLK	$\overline{CCO}$	5	17	5	13	ns
t _{PHL}			6	30	6	25	
t _{PLH}	U/ $\overline{D}$	$\overline{RCO}$	9	31	9	23	ns
t _{PHL}			9	33	9	19	
t _{PLH}	$\overline{ENT}$	$\overline{RCO}$	6	21	6	15	ns
t _{PHL}			4	20	4	13	
t _{PLH}	$\overline{ENT}$	$\overline{CCO}$	5	18	5	13	ns
t _{PHL}			9	32	9	23	
t _{PLH}	$\overline{ENP}$	$\overline{CCO}$	4	18	4	12	ns
t _{PHL}			5	18	5	14	
t _{PHL}	$\overline{ACLR}$	Any Q	9	25	9	20	ns
t _{PZH}	$\overline{OE}$	Any Q	6	23	6	18	ns
t _{PZL}			6	29	6	24	
t _{PHZ}	$\overline{OE}$	Any Q	1	12	1	10	ns
t _{PLZ}			3	29	3	13	

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

SN54ALS569A, SN74ALS568A, SN74ALS569A SYNCHRONOUS 4-BIT UP/DOWN DECADE AND BINARY COUNTERS WITH 3-STATE OUTPUTS

SDAS229A – APRIL 1982 – REVISED JANUARY 1995

PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



- NOTES: A. C_L includes probe and jig capacitance.
 B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
 D. All input pulses have the following characteristics: $PRR \leq 1 \text{ MHz}$, $t_r = t_f = 2 \text{ ns}$, duty cycle = 50%.
 E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
83025022A	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type
8302502RA	ACTIVE	CDIP	J	20	1	TBD	A42	N / A for Pkg Type
8302502SA	ACTIVE	CFP	W	20	1	TBD	Call TI	N / A for Pkg Type
SN54ALS569AJ	ACTIVE	CDIP	J	20	1	TBD	A42	N / A for Pkg Type
SN74ALS568AN	OBSOLETE	PDIP	N	20		TBD	Call TI	Call TI
SN74ALS569ADWR	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ALS569ADWRE4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ALS569ADWRG4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ALS569AN	ACTIVE	PDIP	N	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
SN74ALS569ANE4	ACTIVE	PDIP	N	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
SNJ54ALS569AFK	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type
SNJ54ALS569AJ	ACTIVE	CDIP	J	20	1	TBD	A42	N / A for Pkg Type
SNJ54ALS569AW	ACTIVE	CFP	W	20	1	TBD	Call TI	N / A for Pkg Type

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

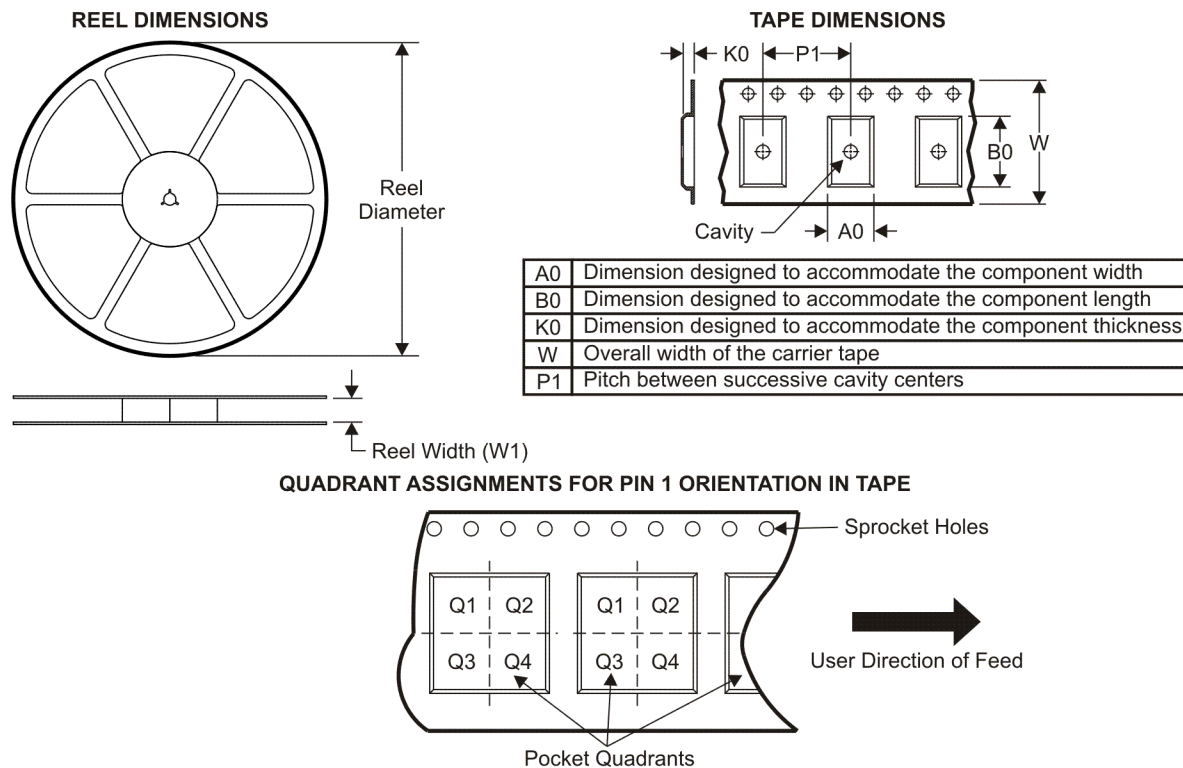
Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

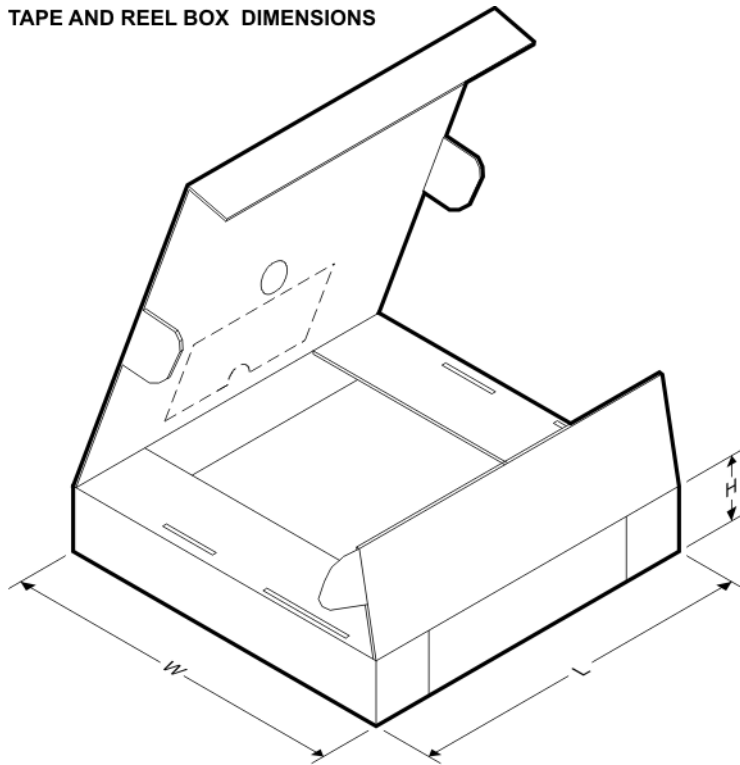
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

TAPE AND REEL INFORMATION


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74ALS569ADWR	SOIC	DW	20	2000	330.0	24.4	10.8	13.0	2.7	12.0	24.0	Q1

TAPE AND REEL BOX DIMENSIONS



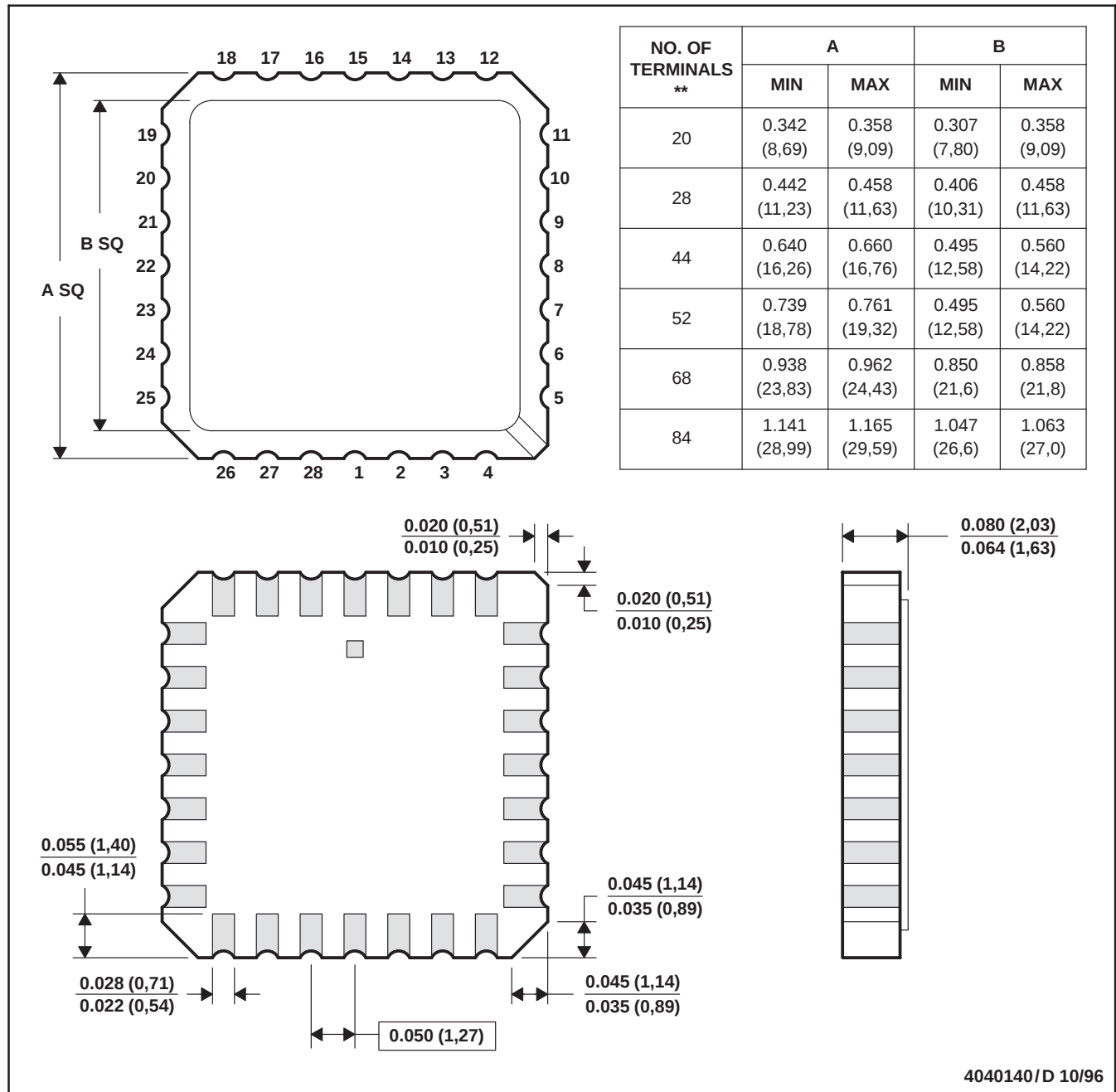
*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74ALS569ADWR	SOIC	DW	20	2000	346.0	346.0	41.0

FK (S-CQCC-N**)

LEADLESS CERAMIC CHIP CARRIER

28 TERMINAL SHOWN

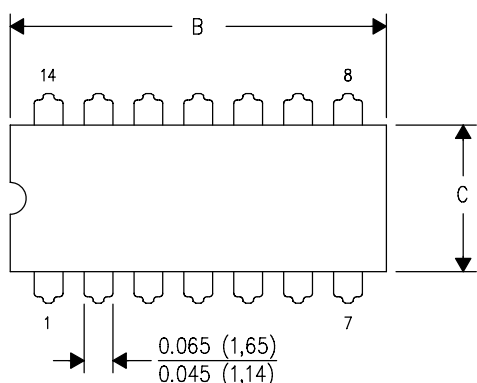


- NOTES:
- All linear dimensions are in inches (millimeters).
 - This drawing is subject to change without notice.
 - This package can be hermetically sealed with a metal lid.
 - The terminals are gold plated.
 - Falls within JEDEC MS-004

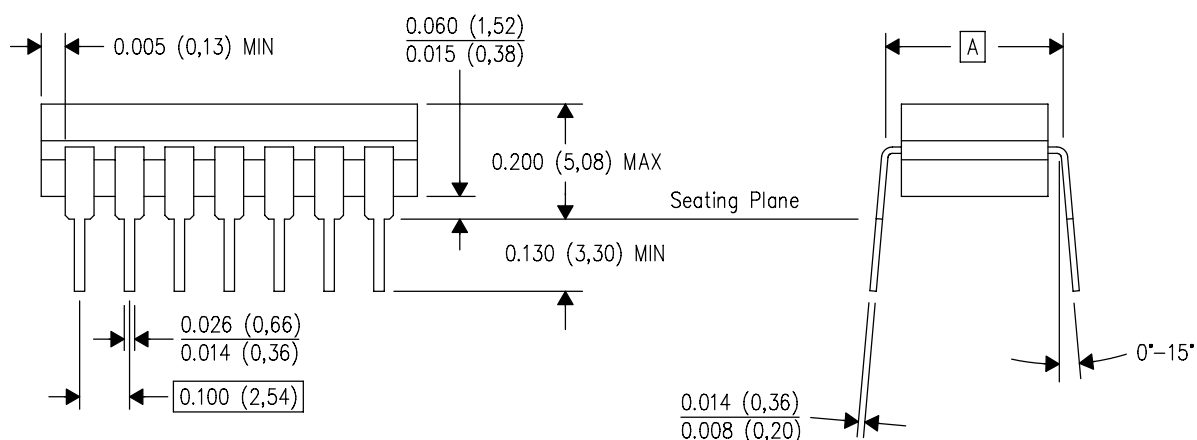
J (R-GDIP-T**)

14 LEADS SHOWN

CERAMIC DUAL IN-LINE PACKAGE



PINS ** DIM	14	16	18	20
A	0.300 (7,62) BSC	0.300 (7,62) BSC	0.300 (7,62) BSC	0.300 (7,62) BSC
B MAX	0.785 (19,94)	.840 (21,34)	0.960 (24,38)	1.060 (26,92)
B MIN	—	—	—	—
C MAX	0.300 (7,62)	0.300 (7,62)	0.310 (7,87)	0.300 (7,62)
C MIN	0.245 (6,22)	0.245 (6,22)	0.220 (5,59)	0.245 (6,22)

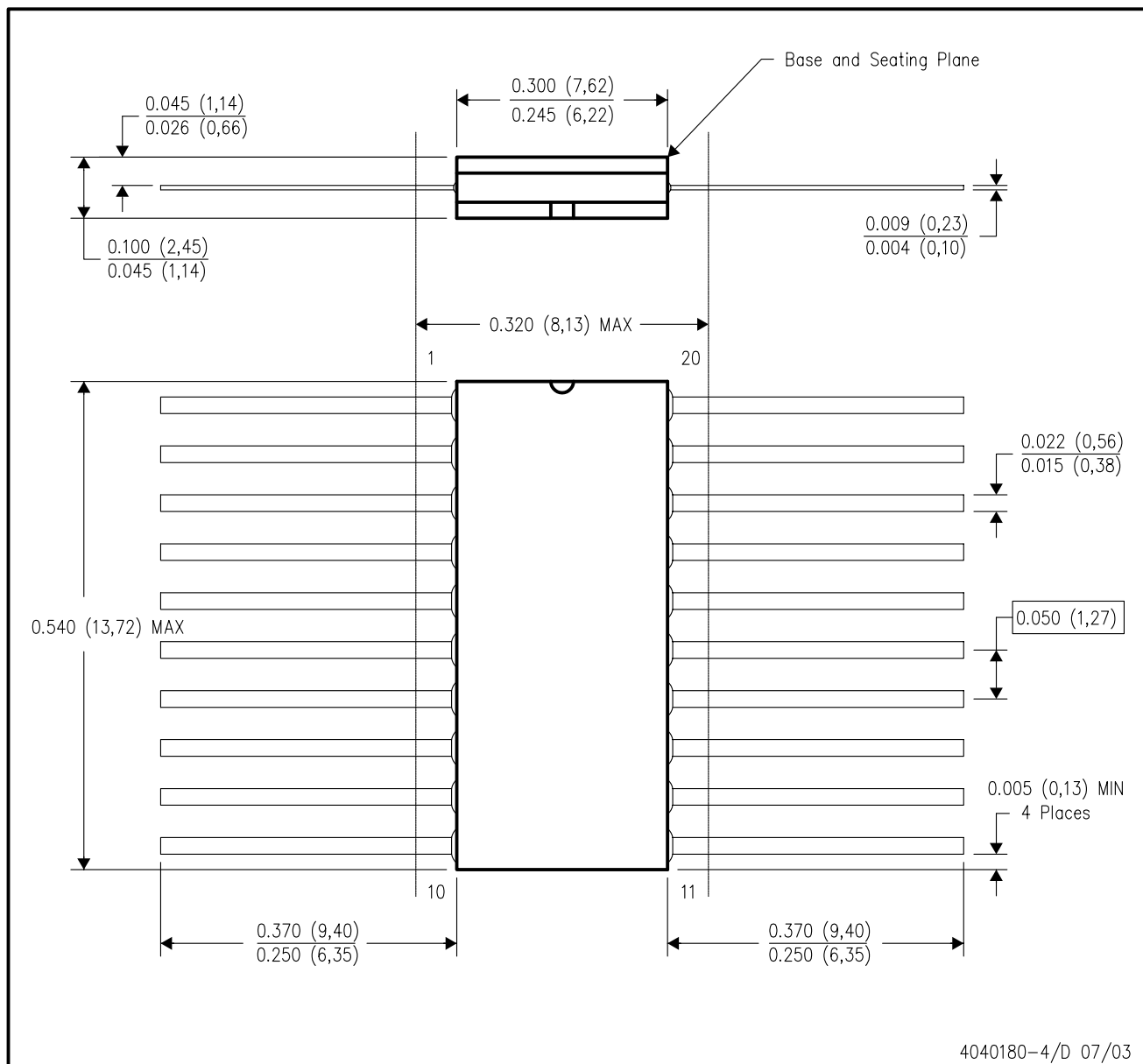


4040083/F 03/03

- NOTES:
- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - C. This package is hermetically sealed with a ceramic lid using glass frit.
 - D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
 - E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

W (R-GDFP-F20)

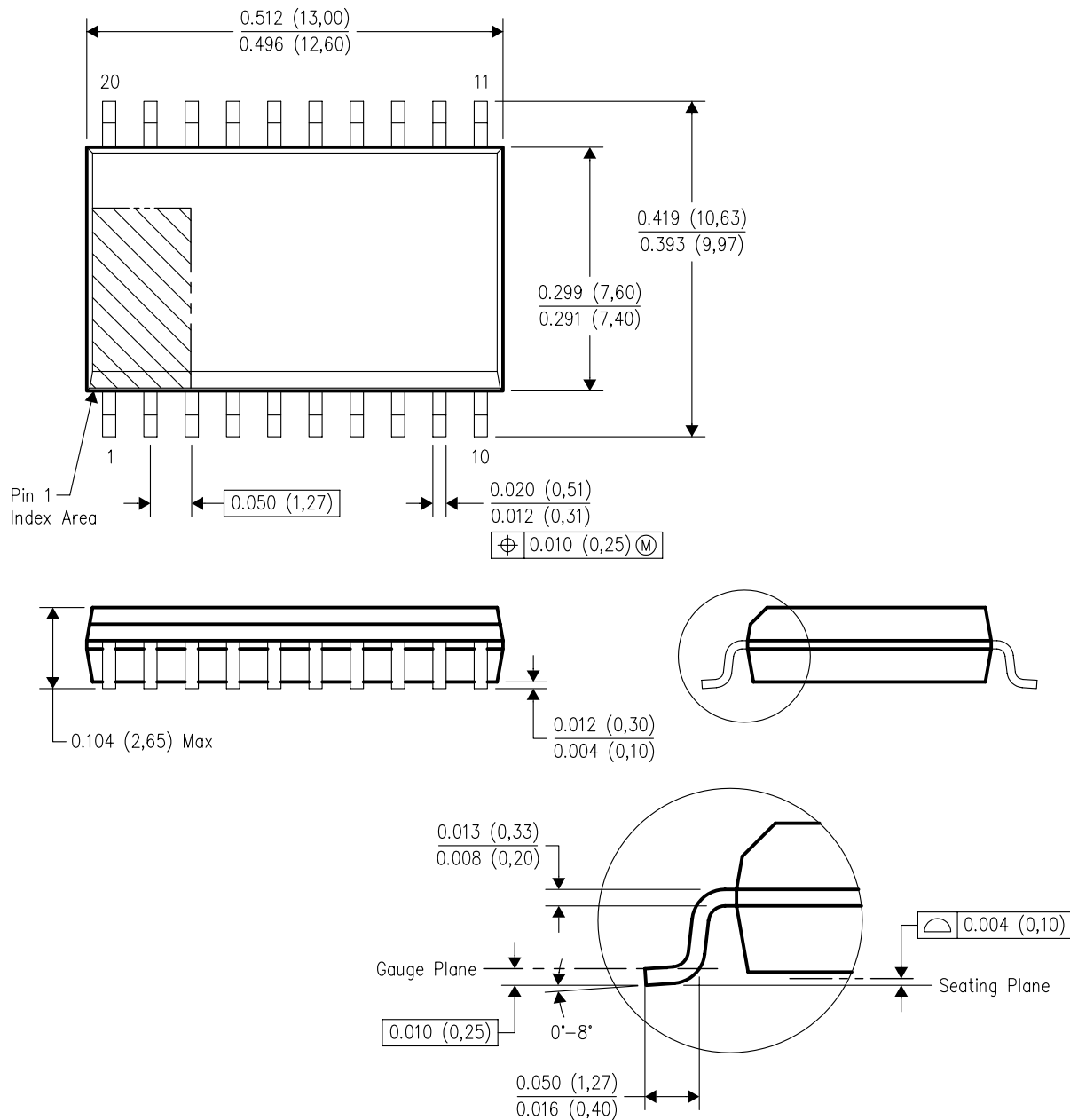
CERAMIC DUAL FLATPACK



- NOTES:
- All linear dimensions are in inches (millimeters).
 - This drawing is subject to change without notice.
 - This package can be hermetically sealed with a ceramic lid using glass frit.
 - Index point is provided on cap for terminal identification only.
 - Falls within Mil-Std 1835 GDFP2-F20

DW (R-PDSO-G20)

PLASTIC SMALL-OUTLINE PACKAGE



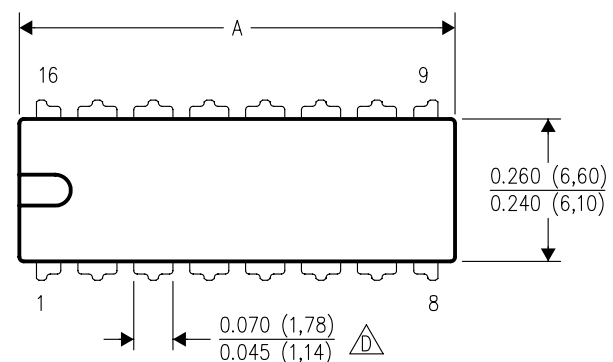
4040000-4/F 06/2004

- NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
D. Falls within JEDEC MS-013 variation AC.

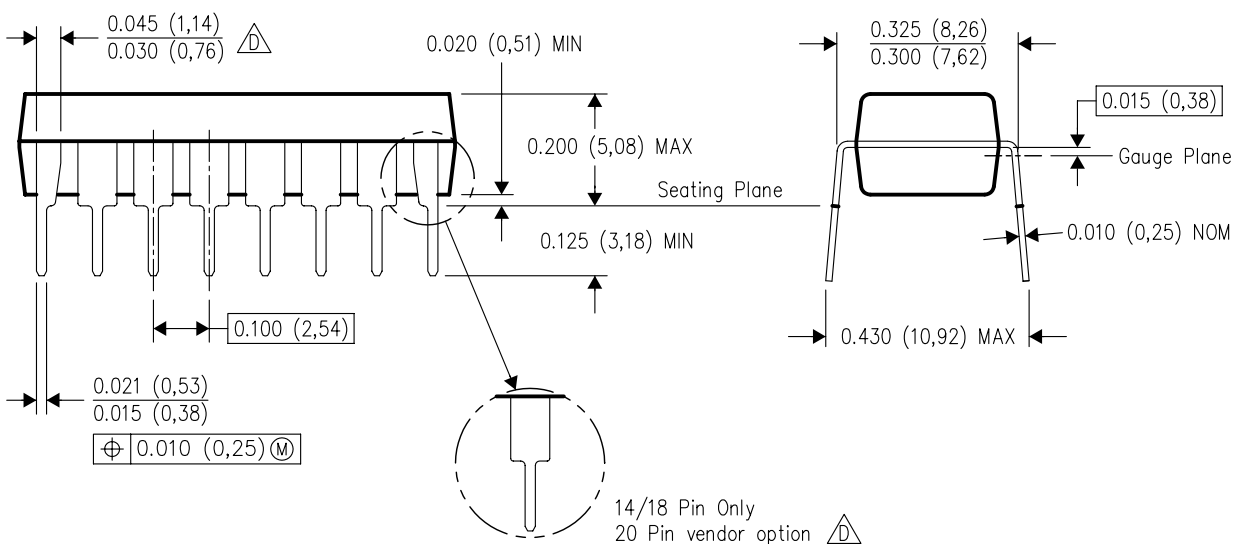
N (R-PDIP-T**)

16 PINS SHOWN

PLASTIC DUAL-IN-LINE PACKAGE



PINS ** DIM	14	16	18	20
A MAX	0.775 (19,69)	0.775 (19,69)	0.920 (23,37)	1.060 (26,92)
A MIN	0.745 (18,92)	0.745 (18,92)	0.850 (21,59)	0.940 (23,88)
MS-001 VARIATION	AA	BB	AC	AD



4040049/E 12/2002

NOTES:

- A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
-  Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
 The 20 pin end lead shoulder width is a vendor option, either half or full width.